

**Notice of References Cited**

Application/Control No.

09/611,021

Applicant(s)/Patent Under  
Reexamination  
KIM ET AL.

Examiner

Sujatha Sharma

Art Unit

2684

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,636,275	06-1997	Takagi et al.	379/433.13
	B	US-6,542,721	04-2003	Boesen, Peter V.	1/1
	C	US-6,615,058	09-2003	Nagai, Michio	455/566
	D	US-6,073,027	06-2000	Norman et al.	455/575.4
	E	US-6,374,089	04-2002	Till, David P.	455/90.1
	F	US-6,131,042	10-2000	Lee et al.	455/556.1
	G	US-6,628,974	09-2003	Lim, Tae Hyeong	379/433.11
	H	US-5,649,309	07-1997	Wilcox et al.	455/575.3
	I	US-2001/0039193	11-2001	Pan, Long-Jyh	455/550
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1009104A2	06-2000	KR	Paek et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.